Document Number: MW4IC2020N
Rev. 9, 5/2006

RoHS

RF LDMOS Wideband Integrated Power Amplifiers

MW4IC2020NBR1
MW4IC2020GNBR1

The MW4IC2020N wideband integrated circuit is designed with on-chip matching that makes it usable from 1600 to 2400 MHz. This multi-stage structure is rated for 26 to 28 Volt operation and covers all typical cellular base station modulation formats.

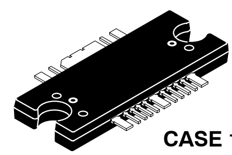
1805-1990 MHz, 20 W, 26 V
GSM/GSM EDGE, CDMA
RF LDMOS WIDEBAND
INTEGRATED POWER AMPLIFIERS

Final Application

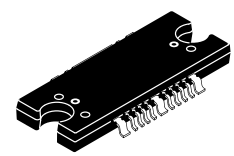
- Typical Two-Tone Performance: V_{DD} = 26 Volts, I_{DQ1} = 80 mA, I_{DQ2} = 200 mA, I_{DQ3} = 300 mA, P_{out} = 20 Watts PEP, Full Frequency Band
  Power Gain — 29 dB
  IMD — -32 dBc
  Drain Efficiency — 26% (at 1805 MHz) and 20% (at 1990 MHz)

Driver Applications

- Typical GSM EDGE Performance: V_{DD} = 26 Volts, I_{DQ1} = 80 mA, I_{DQ2} = 230 mA, I_{DQ3} = 230 mA, P_{out} = 5 Watts Avg., Full Frequency Band
  Power Gain — 29 dB
  Spectral Regrowth @ 400 kHz Offset = -66 dBc
  Spectral Regrowth @ 600 kHz Offset = -77 dBc
  EVM — 1% rms
- Typical CDMA Performance: V_{DD} = 26 Volts, I_{DQ1} = 80 mA, I_{DQ2} = 240 mA, I_{DQ3} = 250 mA, P_{out} = 1 Watt Avg., Full Frequency Band, IS-95 CDMA (Pilot, Sync, Paging, Traffic Codes 8 Through 13), Channel Bandwidth = 1.2288 MHz. PAR = 9.8 dB @ 0.01% Probability on CCDF.
  Power Gain — 30 dB
  ACPR @ 885 kHz Offset = -61 dBc in 30 kHz Bandwidth
  ALT1 @ 1.25 MHz Offset = -69 dBc in 12.5 kHz Bandwidth
  ALT2 @ 2.25 MHz Offset = -59 dBc in 1 MHz Bandwidth
- Capable of Handling 3:1 VSWR, @ 26 Vdc, 1990 MHz, 8 Watts CW Output Power
- Stable into a 3:1 VSWR. All Spurs Below -60 dBc @ 100 mW to 8 W CW P_{out}.
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- On-Chip Matching (50 Ohm Input, DC Blocked, >5 Ohm Output)
- Integrated Temperature Compensation with Enable/Disable Function
- On-Chip Current Mirror g_m Reference FET for Self Biasing Application [(1)]
- Integrated ESD Protection
- 200°C Capable Plastic Package
- N Suffix Indicates Lead-Free Terminations. RoHS Compliant.
- In Tape and Reel. R1 Suffix = 500 Units per 44 mm, 13 inch Reel



CASE 1329-09
TO-272 WB-16
PLASTIC
MW4IC2020NBR1



CASE 1329A-03
TO-272 WB-16 GULL
PLASTIC
MW4IC2020GNBR1

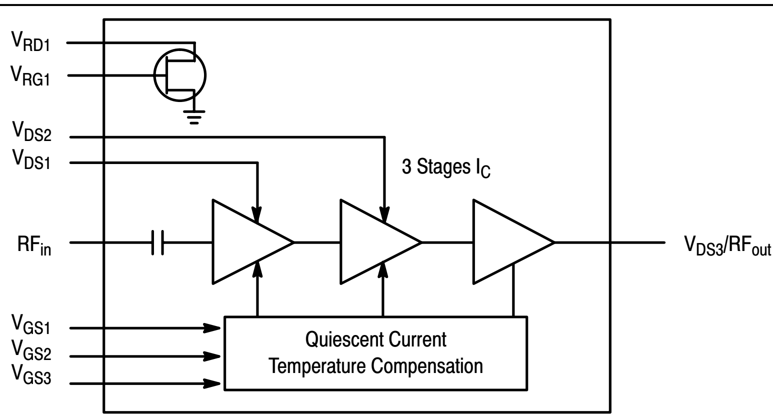
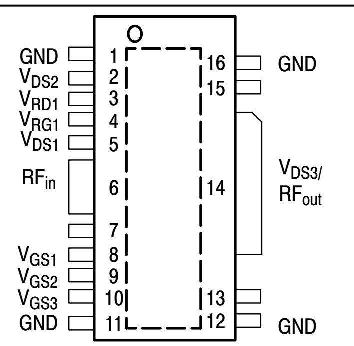


Figure 1. Functional Block Diagram



(Top View)

Note: Exposed backside flag is source terminal for transistors.

Figure 2. Pin Connections

1. Refer to AN1987, *Quiescent Current Control for the RF Integrated Circuit Device Family.* Go to http://www.freescale.com/rf. Select Documentation/Application Notes - AN1987.

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Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-0.5, +65	Vdc
Gate-Source Voltage	V_{GS}	-0.5, +15	Vdc
Storage Temperature Range	T_{stg}	-65 to +175	°C
Operating Junction Temperature	T_J	200	°C
Input Power	P_{in}	20	dBm

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (1)	Unit
Thermal Resistance, Junction to Case Stage 1 Stage 2 Stage 3	$R_{\theta JC}$	 10.5 5.1 2.3	°C/W

Table 3. ESD Protection Characteristics

Test Conditions	Class
Human Body Model	2 (Minimum)
Machine Model	M3 (Minimum)
Charge Device Model	C5 (Minimum)

Table 4. Moisture Sensitivity Level

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD 22-A113, IPC/JEDEC J-STD-020	3	260	°C

Table 5. Electrical Characteristics (T_C = 25°C unless otherwise noted)

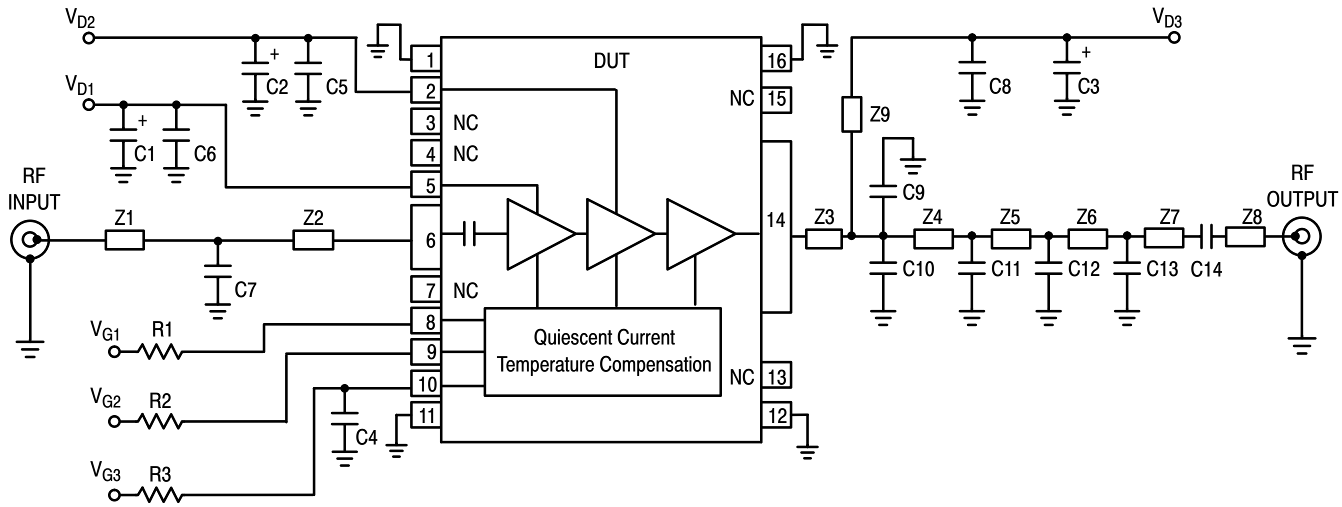
Characteristic	Symbol	Min	Typ	Max	Unit
Functional Tests (In Freescale Wideband 1805-1990 MHz Test Fixture, 50 ohm system) V_{DD} = 26 Vdc, I_{DQ1} = 80 mA, I_{DQ2} = 200 mA, I_{DQ3} = 300 mA, P_{out} = 20 W PEP, f1 = 1990 MHz, f2 = 1990.1 MHz and f1 = 1805 MHz, f2 = 1805.1 MHz, Two-Tone CW					
Power Gain	G_{ps}	27	29	—	dB
Drain Efficiency f1 = 1805 MHz, f2 = 1805.1 MHz f1 = 1990 MHz, f2 = 1990.1 MHz	η_D	 24 18	 26 20	—	%
Input Return Loss	IRL	—	—	-10	dB
Intermodulation Distortion	IMD	—	-32	-27	dBc
Typical Performances (In Freescale Test Fixture, 50 ohm system) V_{DD} = 26 Vdc, I_{DQ1} = 80 mA, I_{DQ2} = 200 mA, I_{DQ3} = 300 mA, 1805 MHz<Frequency<1990 MHz, 1-Tone					
Saturated Pulsed Output Power (f = 1 kHz, Duty Cycle 10%)	P_{sat}	—	33	—	W
Quiescent Current Accuracy over Temperature (-10 to 85°C) (2)	ΔI_{QT}	—	±5	—	%
Gain Flatness in 30 MHz Bandwidth @ P_{out} = 1 W CW	G_F	—	0.15	—	dB
Deviation from Linear Phase in 30 MHz Bandwidth @ P_{out} = 1 W CW 1805-1880 MHz 1930-1990 MHz	Φ	—	 ±0.5 ±0.2	—	°
Delay @ P_{out} = 1 W CW Including Output Matching	Delay	—	1.8	—	ns
Part-to-Part Phase Variation @ P_{out} = 1 W CW	$\Phi\Delta$	—	±10	—	°

1. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers.* Go to http://www.freescale.com/rf. Select Documentation/Application Notes - AN1955.
2. Refer to AN1977, *Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family.* Go to http://www.freescale.com/rf. Select Documentation/Application Notes - AN1977.

(continued)

Table 5. Electrical Characteristics (T_C = 25°C unless otherwise noted) **(continued)**

Characteristic	Symbol	Min	Typ	Max	Unit
Typical CDMA Performances (In Modified CDMA Test Fixture, 50 ohm system) V_{DD} = 26 Vdc, $_{DQ1}$ = 80 mA, I_{DQ2} = 240 mA, I_{DQ3} = 250 mA, P_{out} = 1 W Avg., I1930 MHz<Frequency<1990 MHz, 1-Tone, 9 Channel Forward Model (Pilot, Paging, Sync, Traffic Codes 8 through 13). Peak/Avg. Ratio 9.8 dB @ 0.01% Probability on CCDF.					
Power Gain	G_{ps}	—	30	—	dB
Drain Efficiency	η_D	—	5	—	%
Adjacent Channel Power Ratio (±885 kHz in 30 kHz Bandwidth)	ACPR	—	-61	—	dBc
Alternate 1 Channel Power Ratio (±1.25 MHz in 12.5 kHz Bandwidth)	ALT1	—	-69	—	dBc
Alternate 2 Channel Power Ratio (±2.25 MHz in 1 MHz Bandwidth)	ALT2	—	-59	—	dBc
Typical GSM EDGE Performances (In Modified GSM EDGE Test Fixture, 50 ohm system) V_{DD} = 26 Vdc, I_{DQ1} = 80 mA, I_{DQ2} = 230 mA, I_{DQ3} = 230 mA, P_{out} = 5 W Avg., 1805 MHz<Frequency<1990 MHz					
Power Gain	G_{ps}	—	29	—	dB
Drain Efficiency	η_D	—	15	—	%
Error Vector Magnitude	EVM	—	1	—	% rms
Spectral Regrowth at 400 kHz Offset	SR1	—	-66	—	dBc
Spectral Regrowth at 600 kHz Offset	SR2	—	-77	—	dBc

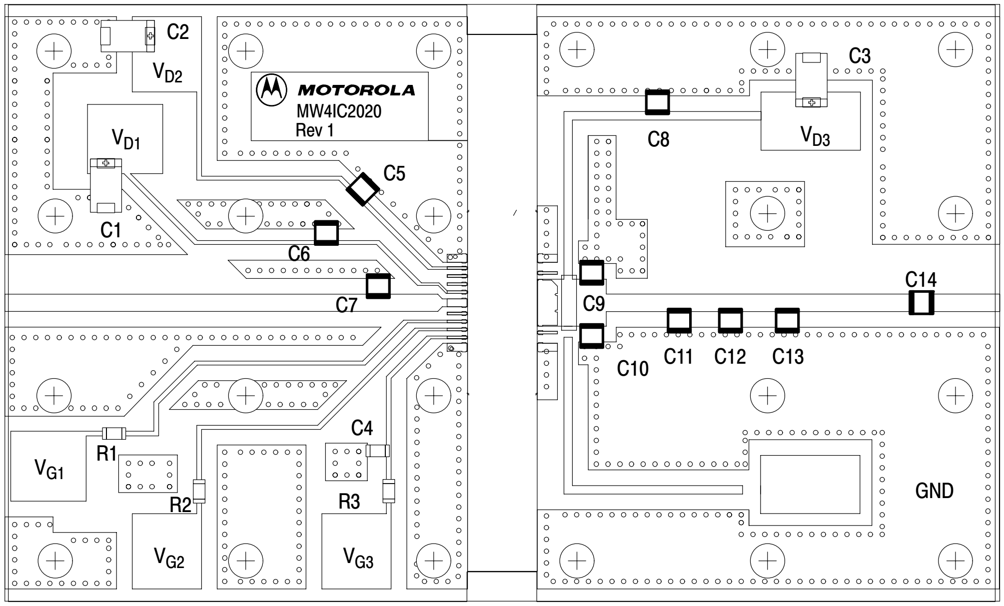


Z1	1.820″ x 0.087″ Microstrip	Z6	0.303″ x 0.087″ Microstrip
Z2	0.245″ x 0.087″ Microstrip	Z7	0.640″ x 0.087″ Microstrip
Z3	0.345″ x 0.236″ Microstrip	Z8	0.334″ x 0.087″ Microstrip
Z4	0.327″ x 0.087″ Microstrip	Z9	1.231″ x 0.043″ Microstrip
Z5	0.271″ x 0.087″ Microstrip	PCB	Taconic TLX8-0300, 0.030″, $\varepsilon_r = 2.55$

Figure 3. MW4IC2020NBR1(GNBR1) Test Circuit Schematic

Table 6. MW4IC2020NBR1(GNBR1) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C2, C3	10 μF, 35 V Tantalum Capacitors	TAJE226M035	AVX
C4	220 nF Chip Capacitor (1206)	12065C224K28	AVX
C5, C6, C8	6.8 pF 100B Chip Capacitors	100B6R8CW	ATC
C7	0.5 pF 100B Chip Capacitor	100B0R5BW	ATC
C9, C11	1.8 pF 100B Chip Capacitors	100B1R8BW	ATC
C10	2.2 pF 100B Chip Capacitor	100B2R2BW	ATC
C12	1 pF 100B Chip Capacitor	100B1R0BW	ATC
C13	0.3 pF 100B Chip Capacitor	100B0R3BW	ATC
C14	10 pF 100B Chip Capacitor	100B100GW	ATC
R1, R2, R3	1.8 kΩ Chip Resistors (1206)		



Freescale has begun the transition of marking Printed Circuit Boards (PCBs) with the Freescale Semiconductor signature/logo. PCBs may have either Motorola or Freescale markings during the transition period. These changes will have no impact on form, fit or function of the current product.

Figure 4. MW4IC2020NBR1(GNBR1) Test Circuit Component Layout

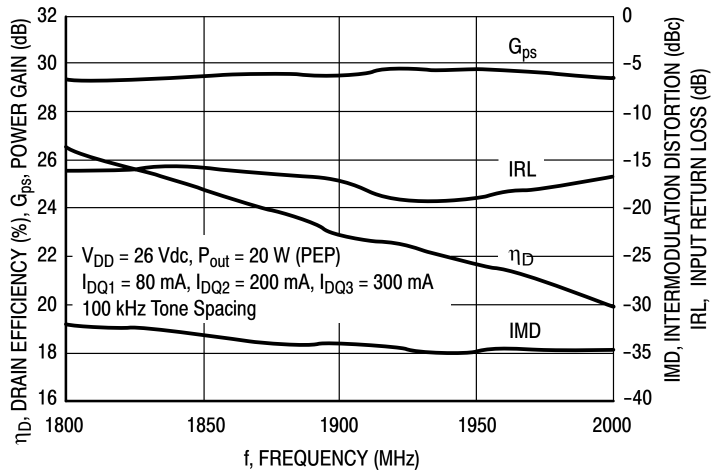


Figure 5. Two-Tone Wideband Performance

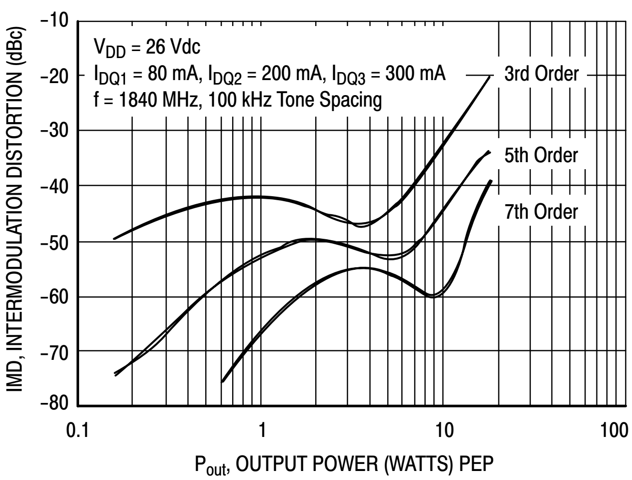


Figure 6. Intermodulation Distortion Products versus Output Power @ 1840 MHz

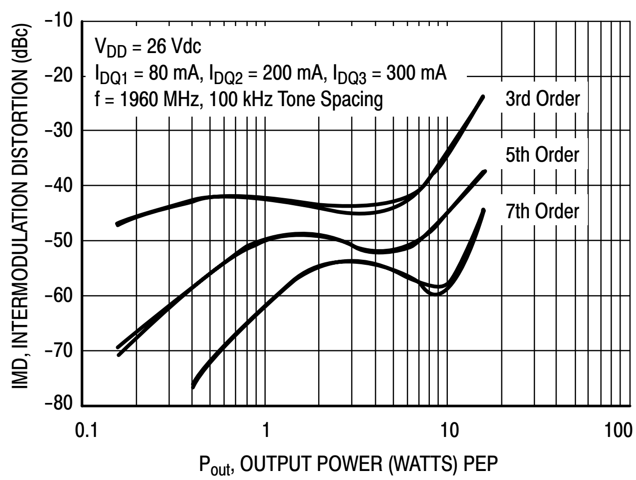


Figure 7. Intermodulation Distortion Products versus Output Power @ 1960 MHz

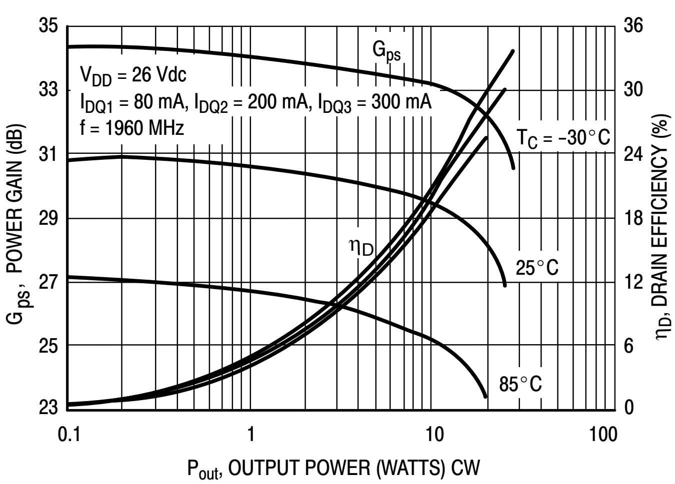


Figure 8. Power Gain and Drain Efficiency versus Output Power

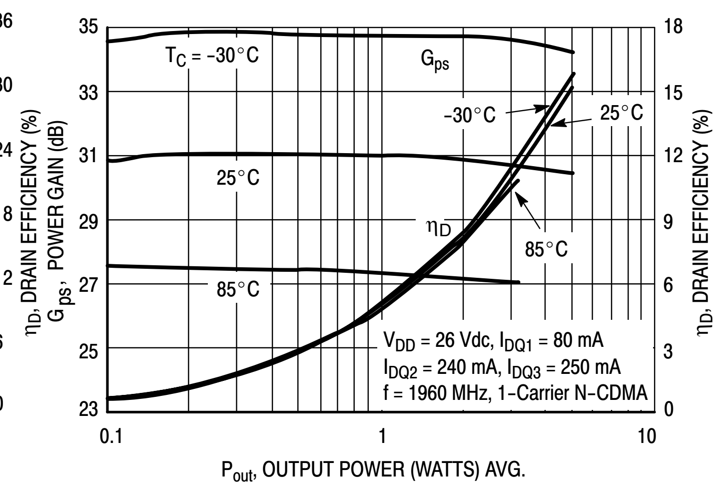


Figure 9. Power Gain and Drain Efficiency versus Output Power

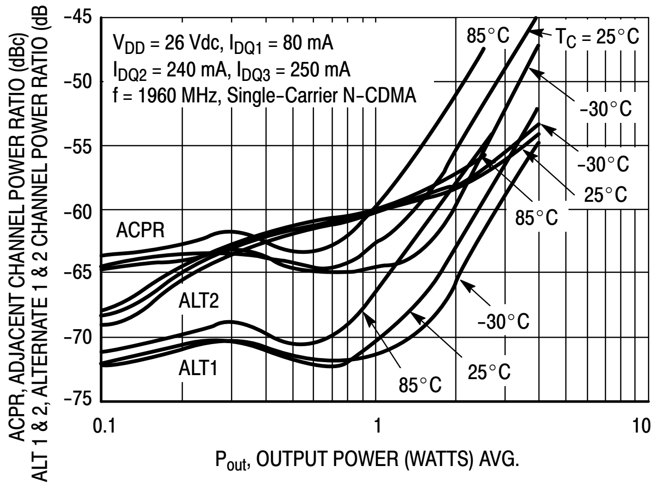


Figure 10. Alternate Channel Power Ratio, Alternate 1 and 2 Channel Power Ratio versus Output Power

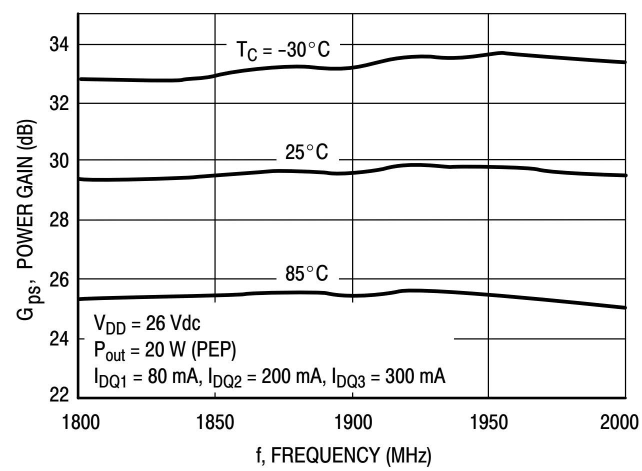


Figure 11. Power Gain versus Frequency

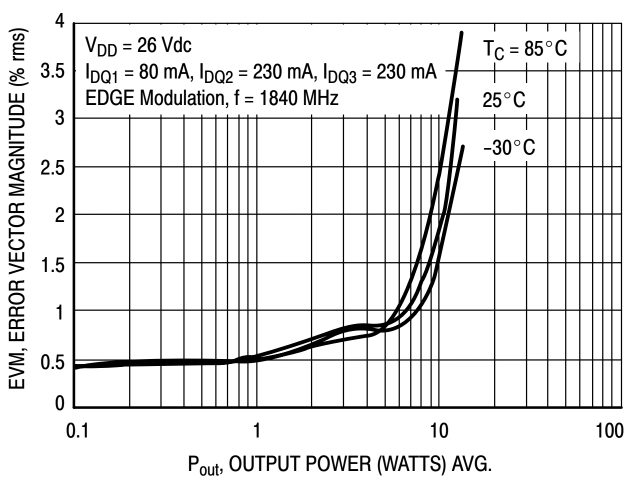


Figure 12. EVM versus Output Power @ 1840 MHz

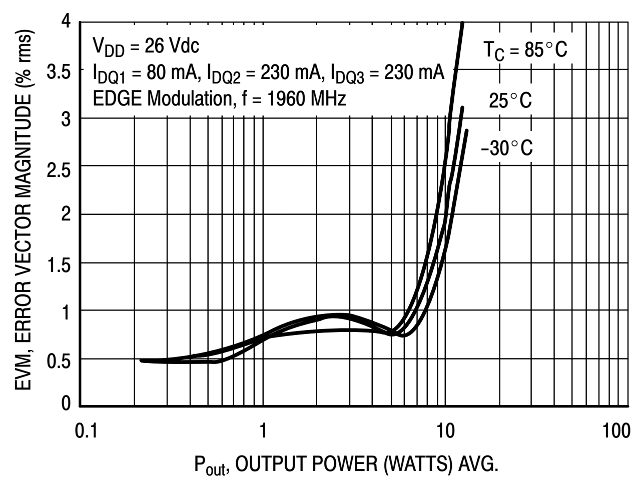


Figure 13. EVM versus Output Power @ 1960 MHz

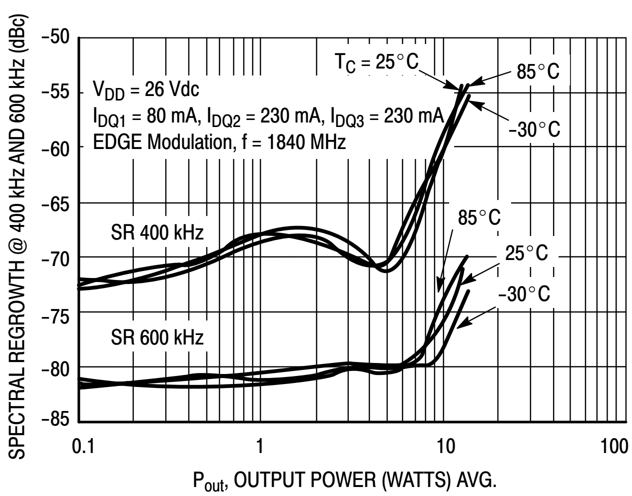


Figure 14. Spectral Regrowth at 400 and 600 kHz versus Output Power @ 1840 MHz

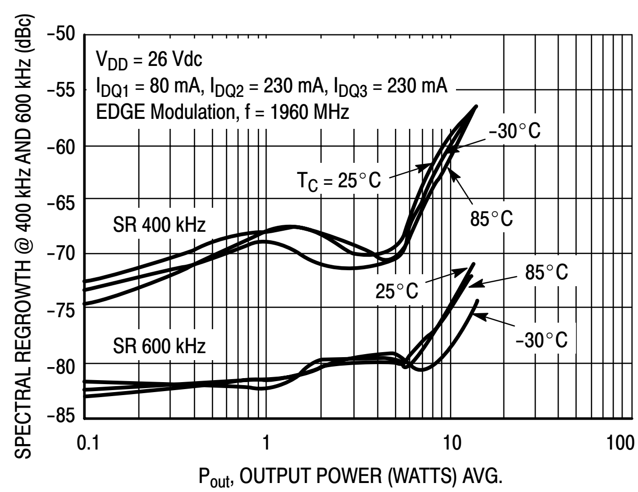
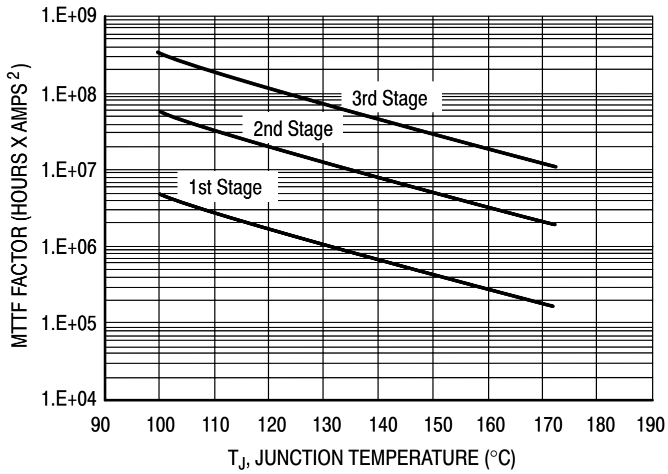
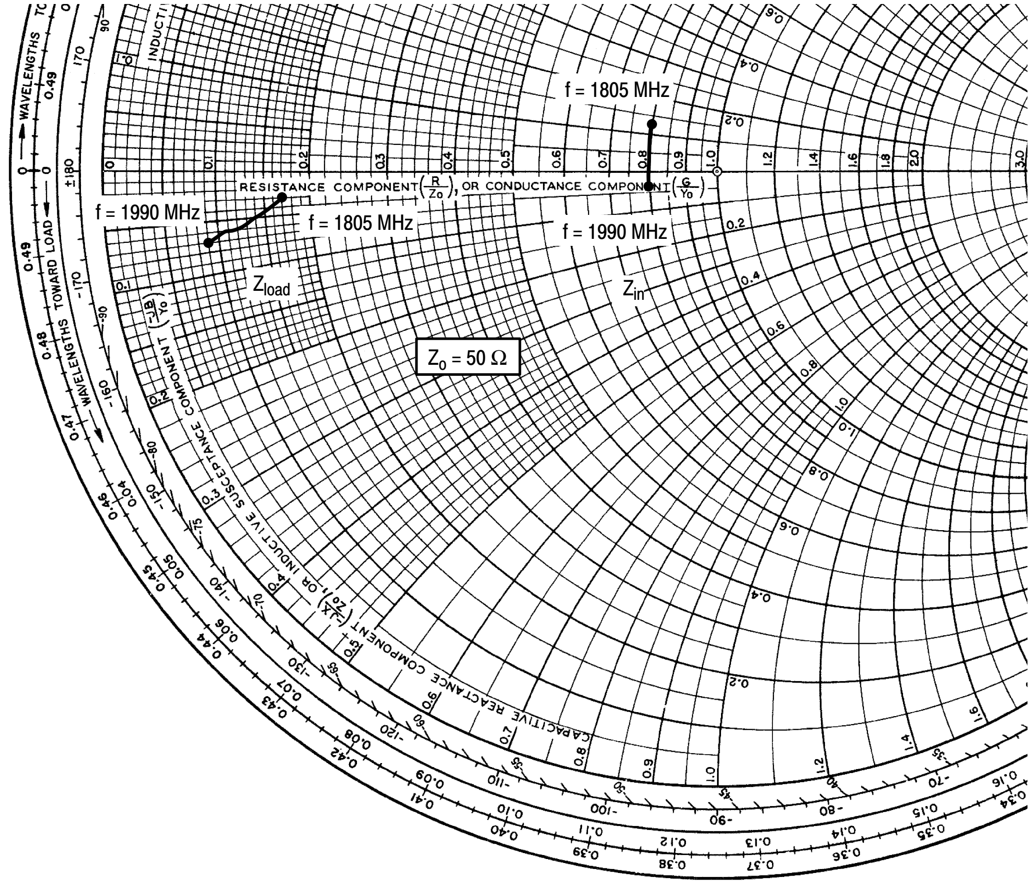


Figure 15. Spectral Regrowth at 400 and 600 kHz versus Output Power @ 1960 MHz



This above graph displays calculated MTTF in hours x ampere^2 drain current. Life tests at elevated temperatures have correlated to better than ±10% of the theoretical prediction for metal failure. Divide MTTF factor by I_D^2 for MTTF in a particular application.

Figure 16. MTTF Factor versus Junction Temperature



V_{DD} = 26 V, I_{DQ1} = 80 mA, I_{DQ2} = 200 mA, I_{DQ3} = 300 mA, P_{out} = 20 W PEP

f MHz	Z_{in} Ω	Z_{load} Ω
1805	40.00 + j6.50	8.75 - j1.42
1842	40.00 + j2.00	7.00 - j2.70
1880	40.00 - j1.50	5.90 - j2.97
1930	40.00 - j1.80	5.46 - j3.20
1960	40.00 - j2.10	4.30 - j3.35
1990	40.00 - j2.60	4.45 - j3.30

Z_{in} = Device input impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

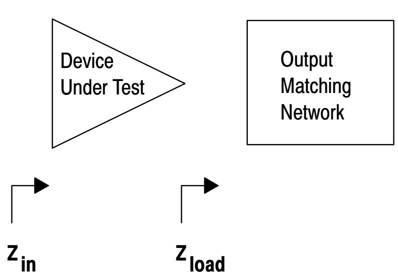
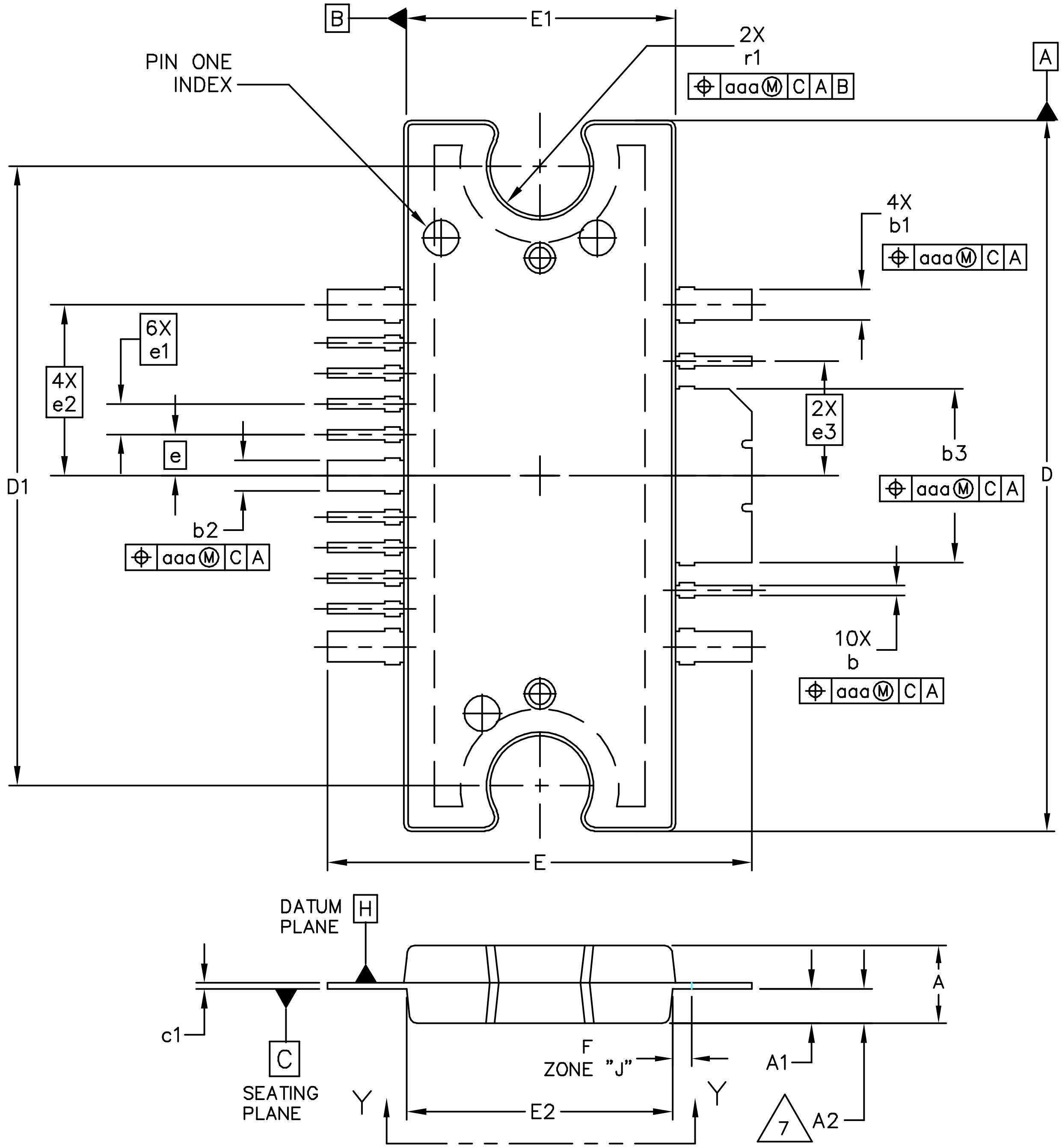


Figure 17. Series Equivalent Input and Load Impedance

PACKAGE DIMENSIONS



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	CASE NUMBER: 1329–09	13 MAR 2006
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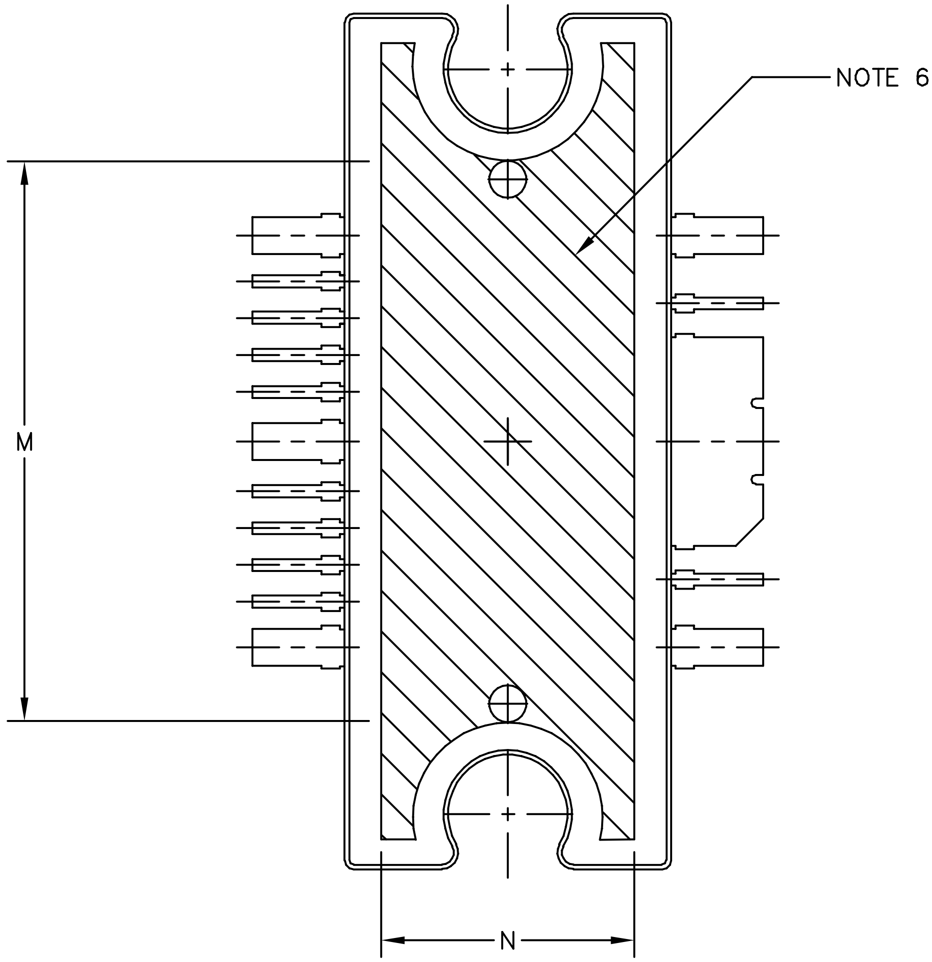

VIEW Y–Y

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NOTES:

1. CONTROLLING DIMENSION: INCH

2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.

3. DATUM PLANE -H- IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.

4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 (0.15) PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.

5. DIMENSIONS "b", "b1", "b2" AND "b3" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 (0.13) TOTAL IN EXCESS OF THE "b", "b1", "b2" AND "b3" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.

6. HATCHING REPRESENTS THE EXPOSED AREA OFTHE HEAT SLUG. HATCHED AREA SHOWN IS ON THE SAME PLANE.

7. DIM A2 APPLIES WITHIN ZONE "J" ONLY.

DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX	DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX
A	.100	.104	2.54	2.64	b	.011	.017	0.28	0.43
A1	.038	.044	0.96	1.12	b1	.037	.043	0.94	1.09
A2	.040	.042	1.02	1.07	b2	.037	.043	0.94	1.09
D	.928	.932	23.57	23.67	b3	.225	.231	5.72	5.87
D1	.810 BSC		20.57 BSC		c1	.007	.011	.18	.28
E	.551	.559	14.00	14.20	e	.054 BSC		1.37 BSC	
E1	.353	.357	8.97	9.07	e1	.040 BSC		1.02 BSC	
E2	.346	.350	8.79	8.89	e2	.224 BSC		5.69 BSC	
F	.025 BSC		0.64 BSC		e3	.150 BSC		3.81 BSC	
M	.600	----	15.24	----	r1	.063	.068	1.6	1.73
N	.270	----	6.86	----					
					aaa	.004		.10	

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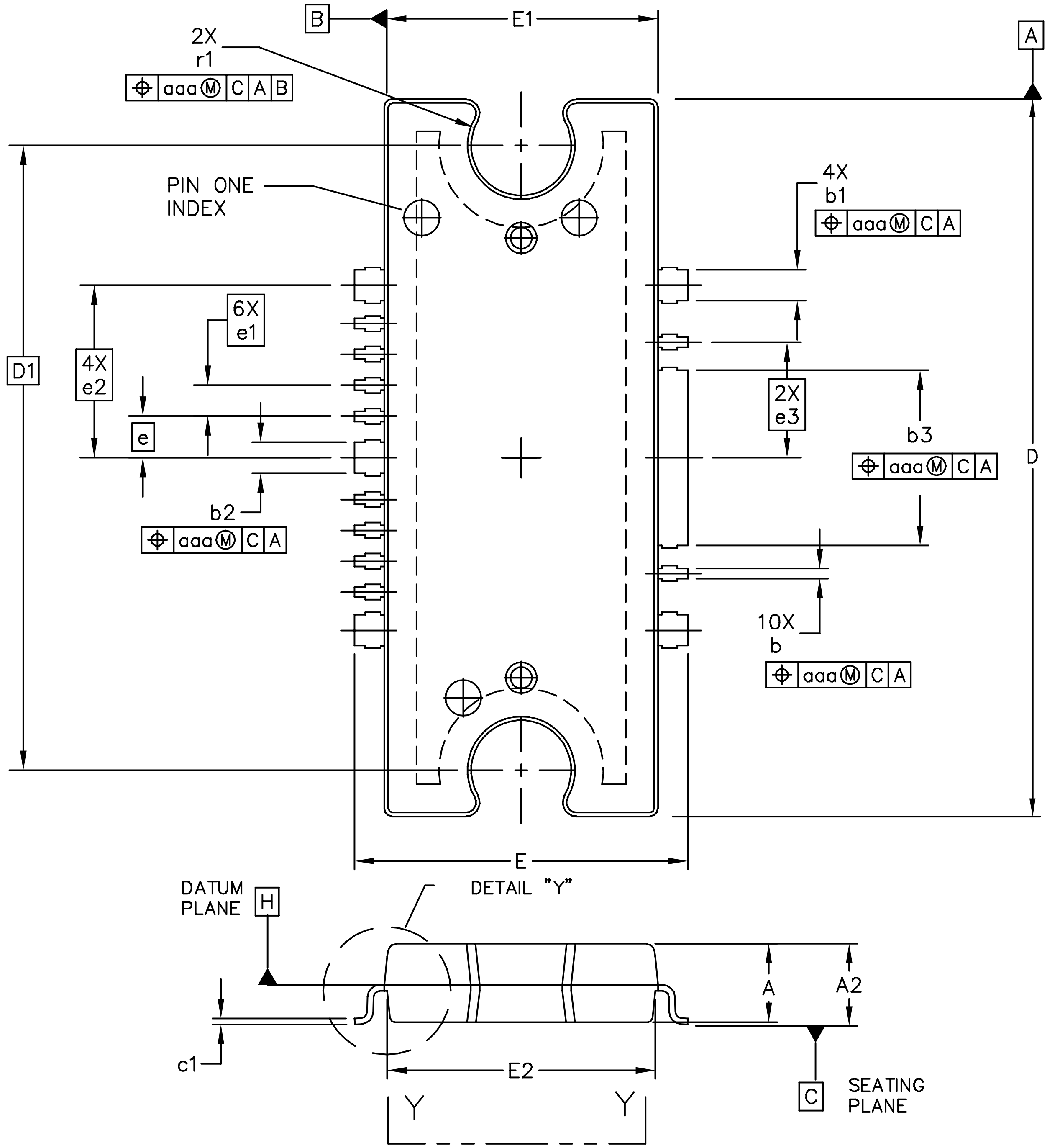

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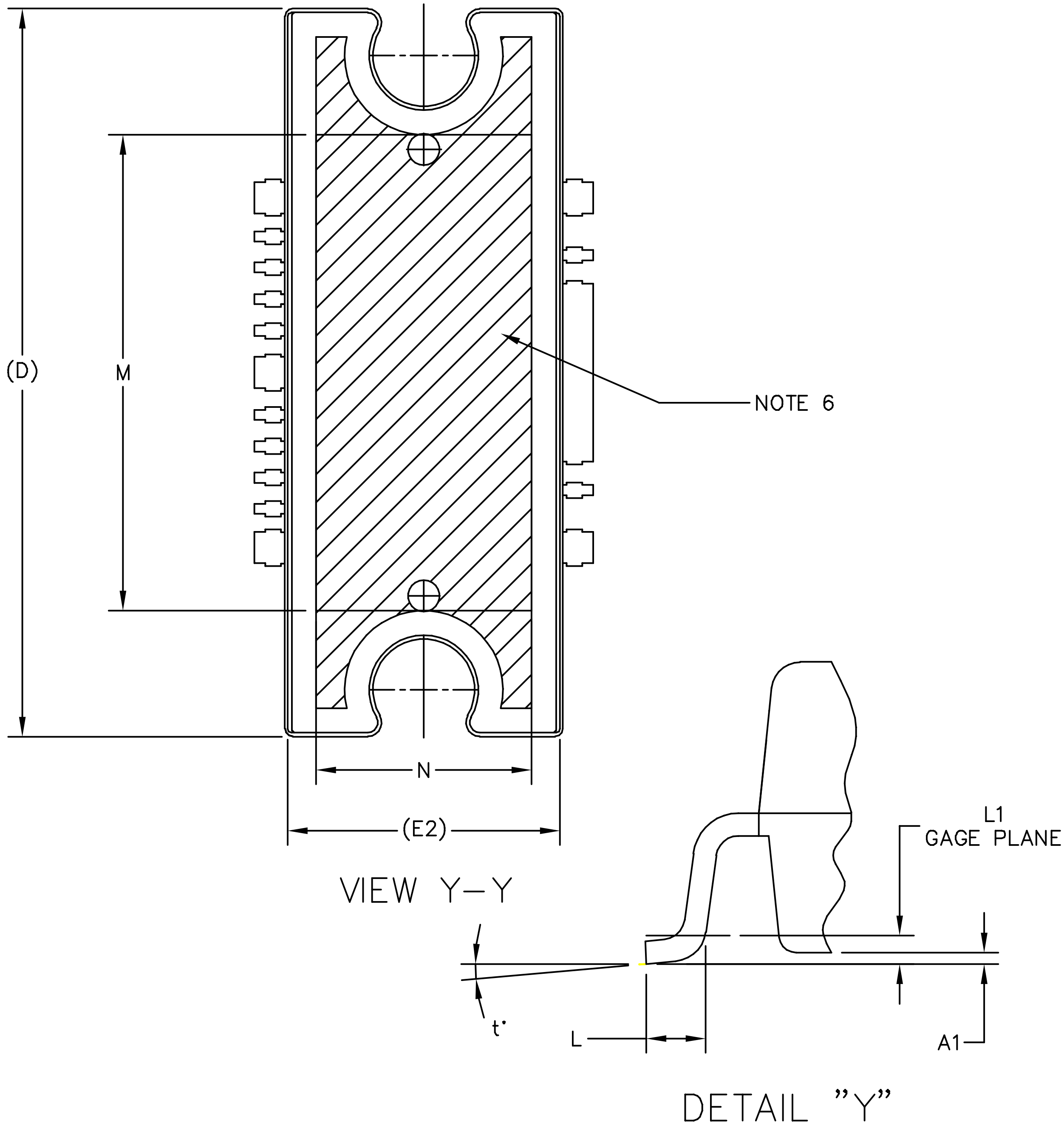

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	CASE NUMBER: 1329A–03	3 APR 2006
	STANDARD: NON–JEDEC	

NOTES:

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6. HATCHING REPRESENTS EXPOSED AREA OF THE HEAT SLUG. HATCHED AREA SHOWN IS ON THE SAME PLANE.

DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX	DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX
A	.100	.104	2.54	2.64	b	.011	.017	0.28	0.43
A1	.001	.004	0.02	0.10	b1	.037	.043	0.94	1.09
A2	.099	.110	2.51	2.79	b2	.037	.043	0.94	1.09
D	.928	.932	23.57	23.67	b3	.225	.231	5.72	5.87
D1	.810 BSC		20.57 BSC		c1	.007	.011	.18	.28
E	.429	.437	10.9	11.1	e	.054 BSC		1.37 BSC	
E1	.353	.357	8.97	9.07	e1	.040 BSC		1.02 BSC	
E2	.346	.350	8.79	8.89	e2	.224 BSC		5.69 BSC	
L	.018	.024	4.90	5.06	e3	.150 BSC		3.81 BSC	
L1	.01 BSC		.025 BSC		r1	.063	.068	1.6	1.73
M	.600	----	15.24	----	t	2°	8°	2°	8°
N	.270	----	6.86						
				----	aaa	.004		.10	

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	CASE NUMBER: 1329A—03	3 APR 2006
	STANDARD: NON—JEDEC	

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